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	BRS	L5	323	2 with 3	US PAT; US - PGPUB	2003/04/07 14:30	
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2	BRS	L12	198207	(Characteristic or temperature or thickness or composition) with (measure or measurement measured or measureing)	t or USPAT; US-PGPUB	20 <b>0</b> 3/04/07 14:58	•
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